Notice of References Cited Application/Control No. 09/775,347 Examiner William C. Vaughn, Jr. Applicant(s)/Patent Under Reexamination YEMINI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name ·	Classification
	Α	US-2002/0012320	01-2002	Ogier et al.	370/252
	В	US-6,717,921	04-2004	Aggarwal et al.	370/256
	С	US-5,870,564	02-1999	Jensen et al.	709/241
	D	US-5,655,134	08-1997	Yamazaki, Yasushi	712/1
	E	US-4,939,726	07-1990	Flammer et al.	370/400
	F.	US-6,728,205	04-2004	Finn et al.	370/217
	G	US-6,597,658	07-2003	Simmons, Jane Marie	370/221
	Н	US-2001/0040895	11-2001	Templin, Fred Lambert	370/466
	1	US-2002/0080790	06-2002	Beshai, Maged E.	370/392
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	<u>.</u>				
	0					
	Р					
	a					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

<u> </u>								
*	1	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	٧							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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